

PCN Number:	20130722002		PCN Date:	07/23/2013	
Title:	TPS71501-Q1 datasheet - CMS C1307004				
Customer Contact:	PCN Manager	Phone:	+1(214) 480-6037	Dept:	Quality Services
Change Type:					
<input type="checkbox"/>	Assembly Site	<input type="checkbox"/>	Assembly Process	<input type="checkbox"/>	Assembly Materials
<input type="checkbox"/>	Design	<input checked="" type="checkbox"/>	Electrical Specification	<input type="checkbox"/>	Mechanical Specification
<input type="checkbox"/>	Test Site	<input type="checkbox"/>	Packing/Shipping/Labeling	<input type="checkbox"/>	Test Process
<input type="checkbox"/>	Wafer Bump Site	<input type="checkbox"/>	Wafer Bump Material	<input type="checkbox"/>	Wafer Bump Process
<input type="checkbox"/>	Wafer Fab Site	<input type="checkbox"/>	Wafer Fab Materials	<input type="checkbox"/>	Wafer Fab Process
PCN Details					
Description of Change:					
Texas Instruments publication SGLS272F will change as described below: Page 3, Electrical Characteristics table, define Output Current limit test conditions for both $V_{IN} \geq 3.5V$ and $< 3.5V$.					
Reason for Change:					
Update datasheet to reflect the current limit test conditions.					
Anticipated impact on Fit, Form, Function, Quality or Reliability (positive / negative):					
No anticipated impact. This is a specification change announcement only. There are no changes to the actual devices.					
Changes to product identification resulting from this PCN:					
None					
Product Affected:					
TPS71501QDCKRQ1 TPS71525QDCKRQ1 TPS71530QDCKRQ1 TPS71533QDCKRQ1 TPS71550QDCKRQ1					

For questions regarding this notice, e-mails can be sent to the regional contacts shown below or your local Field Sales Representative.

Location	E-Mail
USA	PCNAmericasContact@list.ti.com
Europe	PCNEuropeContact@list.ti.com
Asia Pacific	PCNAsiaContact@list.ti.com
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